

US Tech Test Report:
FCC ID:
IC:
Test Report Number:
Issue Date:
Customer:
Model:

FCC Part 15 Certification
2AL4P-SEN4W
22720-SEN4W
17-0127
July 17, 2017
Tymtix Technologies
SEN4W

Test Configuration Photographs



Figure 1. EUT on Test Table

US Tech Test Report:
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Tymtix Technologies
SEN4W

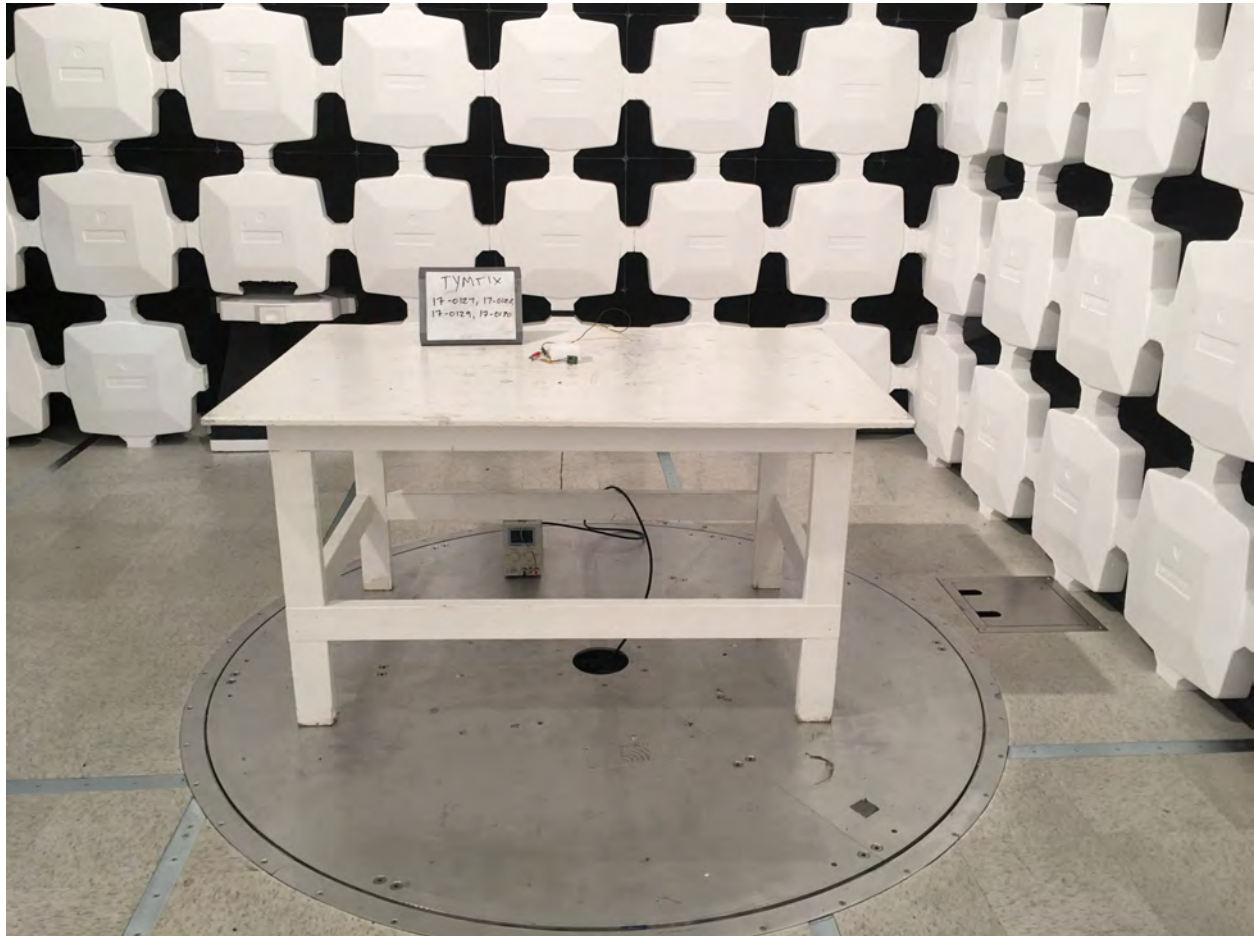


Figure 2. Test Configuration for Testing Below 1 GHz

US Tech Test Report:
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Figure 3. Test Configuration for above 1 GHz (Intentional Emissions)

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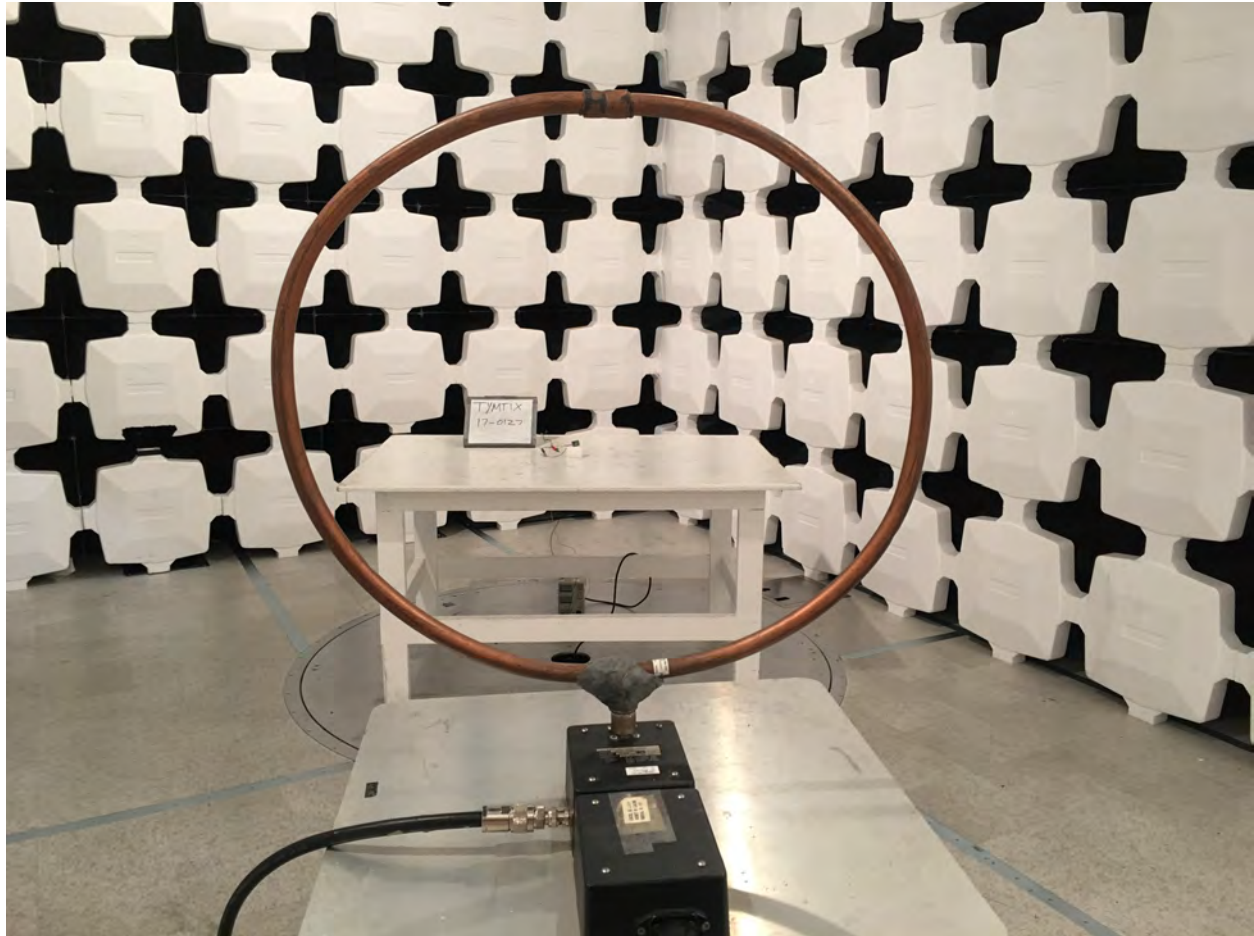


Figure 4. Test Configuration below 30 MHz

US Tech Test Report:
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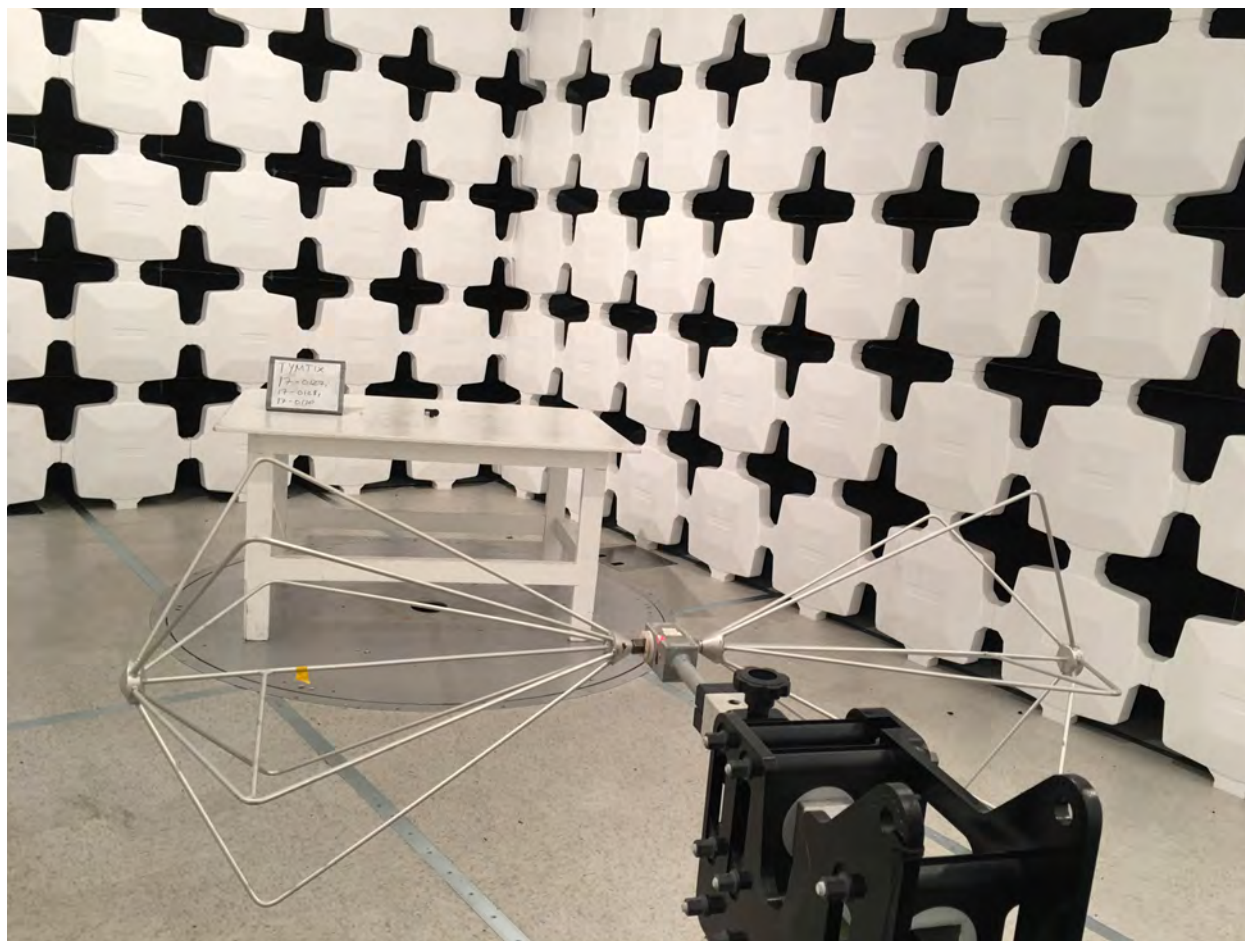


Figure 5. Test Configuration 30 to 200 MHz

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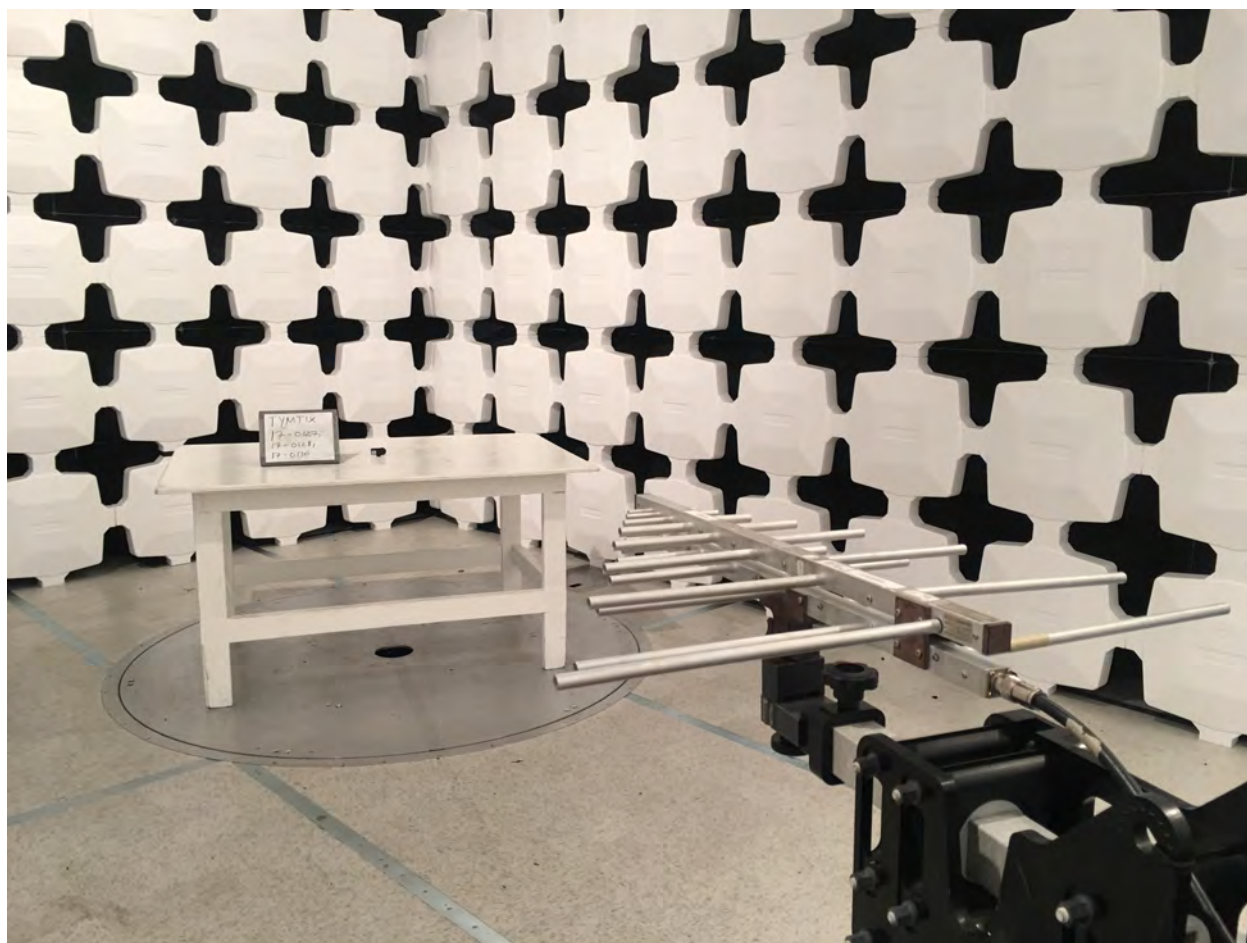


Figure 6. Test Configuration 200 MHz to 1 GHz

US Tech Test Report:
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Model:

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Figure 7. Test Configuration above 1 GHz